



Schedule of Scope to Certificate of Conformity

Independent Testing Laboratory

IECQ Certificate No.: IECQ-L LCIE 25.0001

CB Certificate No.: 25297957-808978

Schedule Number: IECQ-L LCIE 25.0001-S

Rev No.: 01

Revision Date: 2025/06/02

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TEST		RANGE	STANDARD
Electric and electronic equipment and metal materials	Environmental testing - Test Ka: Salt mist	-	CEI EN IEC 60068-2-11:2022
Electric, electronic and mechanical equipment, components and materials	Environmental testing - Test A: Cold	-20°C to -40°C	CEI EN 60068-2-1:2007 - only Ab
Electric, electronic and mechanical equipment, components and materials	Environmental testing - Test Nb: Change of temperature	-40°C a +150°C max variation 5K/min. (Nb)	CEI EN IEC 60068-2-14:2024
Electric, electronic and mechanical equipment, components and materials	Environmental testing - Test B: Dry heat	+40°C to +150°C	CEI EN 60068-2-2:2008
Apparecchiature elettriche, elettroniche e meccaniche, componenti e materiali/Electric, electronic and mechanical equipment, components and materials	Prove ambientali - Prova Db: Caldo umido, ciclico (ciclo di 12h + 12h)/Environmental testing - Test Db: Damp heat, cyclic (12 h + 12 h cycle)	40°C - 60°C; max 98%RH	CEI EN 60068-2-30:2006
Electric, electronic and mechanical equipment, components and materials	Environmental testing - Test Cab: Damp heat, steady state	10°C to 90°C; 20%-95%	CEI EN 60068-2-78:2013
Connectors for electronic equipment	Contact resistance	>1mohm; ADC	CEI EN 60512-2-1:2003
Connectors for electronic equipment	Contact resistance	>0,1mV; 1A to 1900A; ADC	CEI EN 60512-2-2:2003
Connectors for electronic equipment	Temperature rise	1A to 1900A	EN 60512-5-1:2002, IEC 60512-5-1:2002
Connectors for electronic equipment	Insulation resistance	100VDC to 1000VDC; 10Mohm to 100Gohm	CEI EN 60512-3-1:2002
Connectors for electronic equipment	Current-temperature derating	1A to 1900A	EN 60512-5-2:2002, IEC 60512-5-2:2002
Connectors for electronic equipment	Voltage tests	1000V-40000VAC 50Hz	CEI EN 60512-4-1:2003, EN 60512-4-1:2003, IEC 60512-4-1:2003
Connectors for electronic equipment	Circuit integrity, Resistenza di contatto/Test 2f: Housing (shell) electrical continuity	0,1mV to 100mv - 0,1A to 1 A	CEI EN 60512-2-6:2003, EN 60512-2-6:2002, IEC 60512-2-6:2002

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